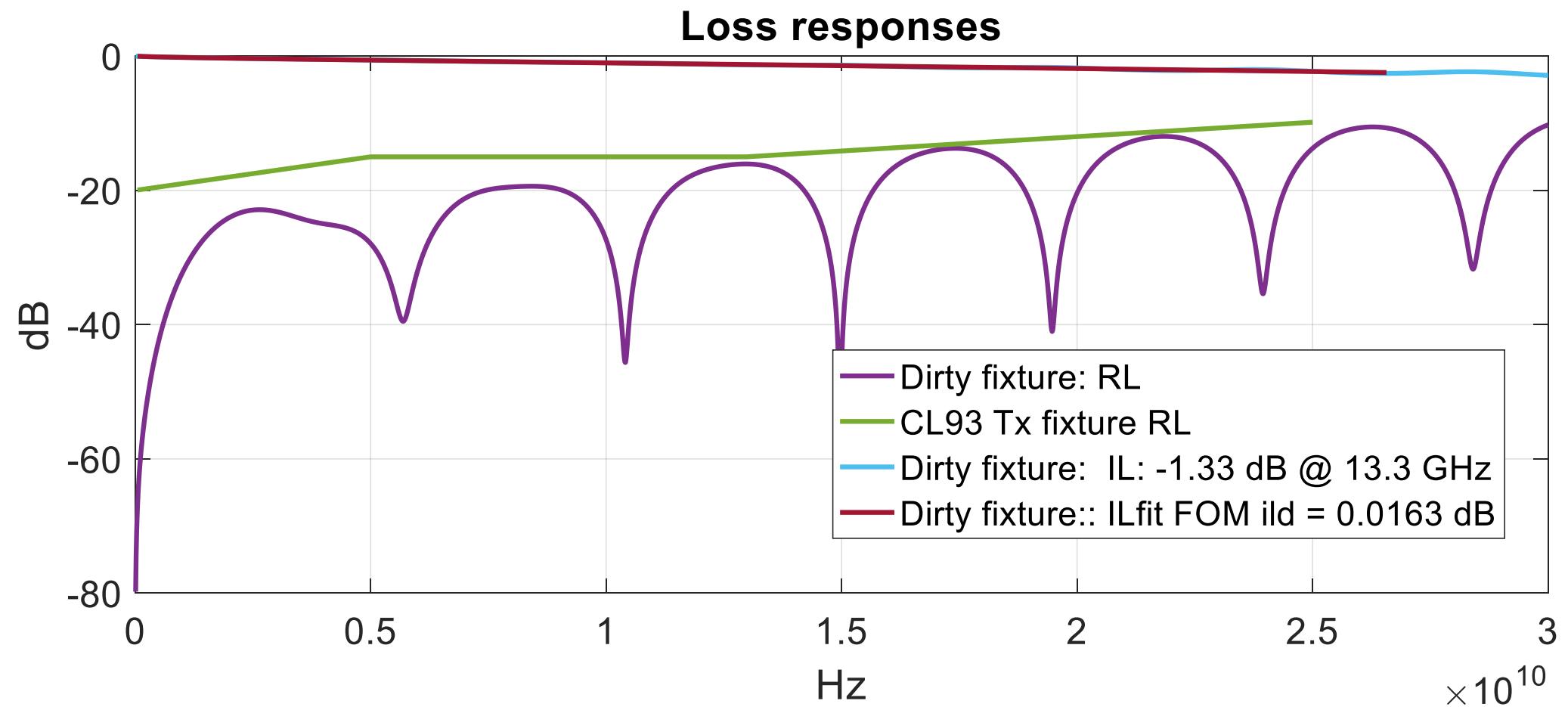


Impact of Test Fixtures on ERL, RL, SNR_{ISI} using COM and with Package Product Examples

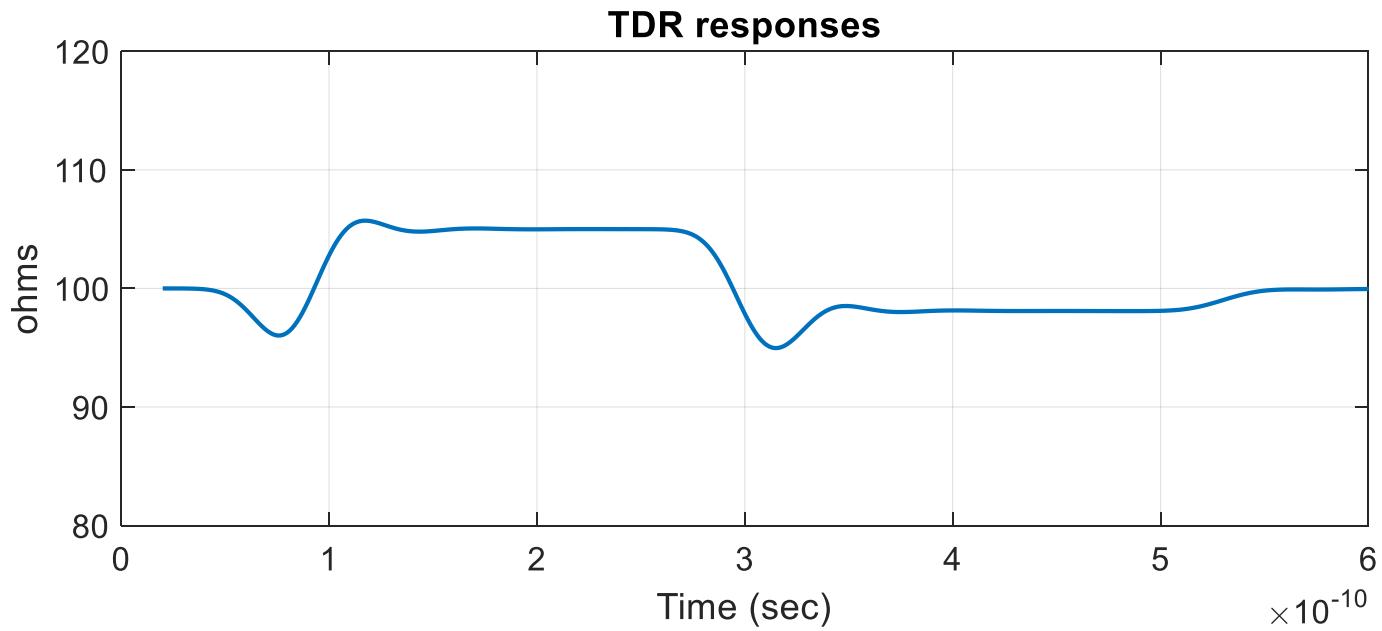
Richard Mellitz. Samtec

11/22/2017

Test fixture with 1.2 to 1.6 dB IL and < 0.1 dB FOM ILD, A somewhat “dirty fixture”, but passing



TDR of test Fixture (w Butterworth filter and 13 ps 20%-80% Gaussian edge transition time)

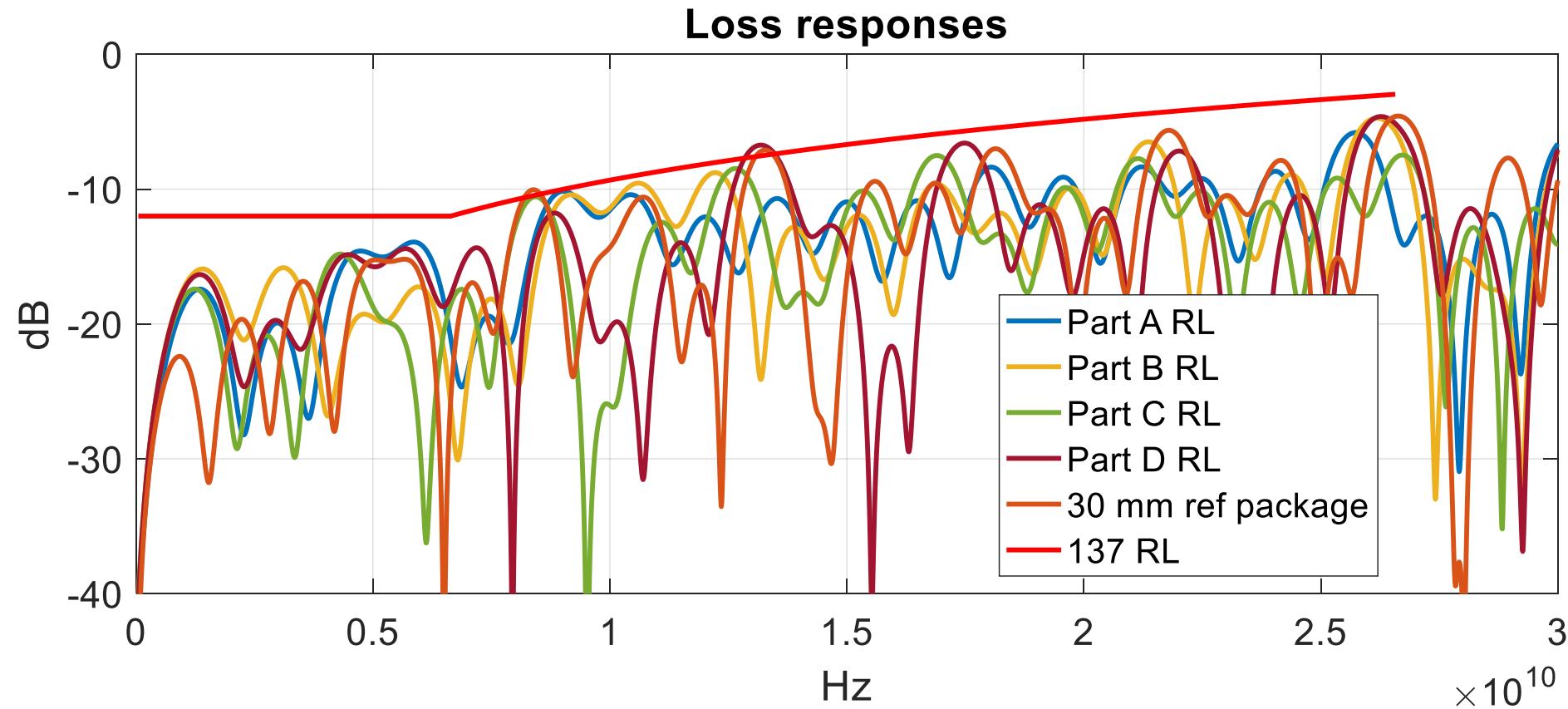


4 packages consider and the 30 mm reference package

- Part a 19mm rx
- Part b 14mm tx
- Part c 14mm rx
- Part d 17mm tx

- Manufacturing variations and actual die load not included yet
- Die load used for all
 - 180 fF for Cd
 - 50 ohm for Rd
- Package to board model (Cp)
 - Cp is included in the Parts. I.e. for computations Cp=0
 - Cp=110 fF for reference package

Return loss results take a bit of effort to unwind



ERL and SNR_{ISI} Results ... so far

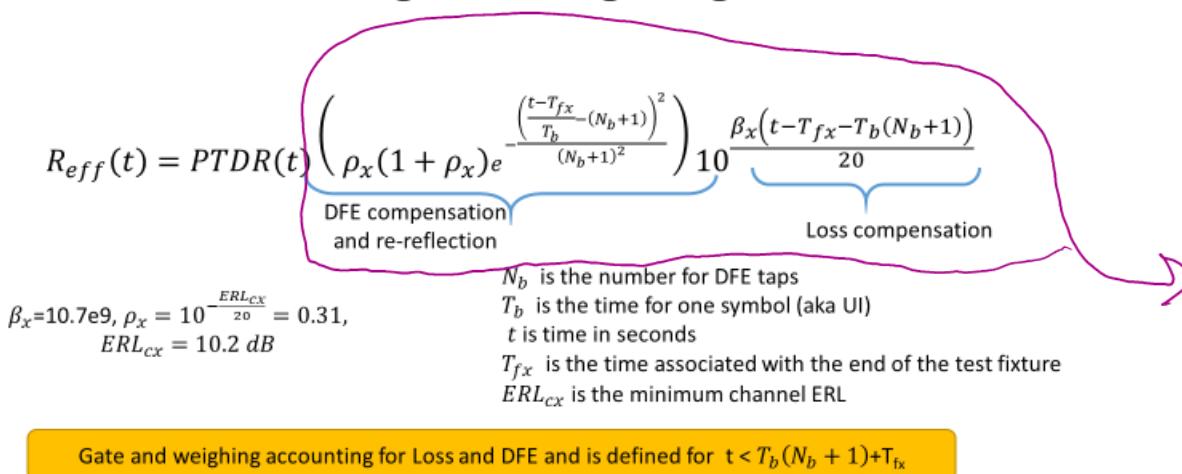
	SNR _{ISI} (dB)	ERL (dB)	COM (dB)
Part A	43.7	24.3	4.0
Part B	44.2	23.7	3.8
Part C	40.2	22.8	3.5
Part D	38.8	22.9	3.8
30 mm reference package	38.8	18.4	3.5
Passing D3.0 and ERL proposal	43	18.6	3.0

Discussion: Conclusions and Follow-on Work

ERL parameters and Channel

- Channel used for testing: Ch8_30_8F_t.s4p
 - http://www.ieee802.org/3/cd/public/channel/Cisco_Backplane_channel_data.zip
- ERL parameters: $\beta_x = 10.7E9$, $\rho_x = .31$, $T_{fx} = 4.604e-10$, $Tr=18.9ps$, Rx filter = Butterworth as in COM, PAM4 data, $DERO = 1e-4$

Effective reflection waveform, $R_{eff}(t)$, is a $PTDR(t)$ filtered with a time gated weighting function



IEEE 802.3 50 Gb/s, 100 Gb/s, and 200 Gb/s Ethernet Task Force

